	Application No.	lication No. Applicant(s)	
	10/724,535	MOLNAR, CHARLES J.	
Notice of Allowability	Examiner	Art Unit	
	Anthony Ojini	3723	
The MAILING DATE of this communication apperaised All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT Right of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this app or other appropriate communication GHTS. This application is subject to	blication. If not included will be mailed in due course. <b>THIS</b>	ive
1. This communication is responsive to <u>CIP filed 11/29/03</u> .			
2. ☑ The allowed claim(s) is/are <u>1-139</u> .			
3. $\boxtimes$ The drawings filed on <u>29 November 2003</u> are accepted by	the Examiner.	•	
4. Acknowledgment is made of a claim for foreign priority un  a) All b) Some* c) None of the:  1. Certified copies of the priority documents have  2. Certified copies of the priority documents have  3. Copies of the certified copies of the priority documents have  International Bureau (PCT Rule 17.2(a)).  * Certified copies not received:  Applicant has THREE MONTHS FROM THE "MAILING DATE" on the delow. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.  5. A SUBSTITUTE OATH OR DECLARATION must be submit INFORMAL PATENT APPLICATION (PTO-152) which give comply including changes required by the Notice of Draftspers  1) hereto or 2) to Paper No./Mail Date  (b) including changes required by the attached Examiner's Paper No./Mail Date  Identifying Indicia such as the application number (see 37 CFR 1. each sheet. Replacement sheet(s) should be labeled as such in the such as the should be labeled as such in the such as the should be labeled as such in the such as the should be labeled as such in the such as the should be labeled as such in the such as the should be labeled as such in the such as the should be labeled as such in the such as the should be labeled as such in the such as the should be labeled as such in the such as the should be labeled as such in the such as the should be labeled as such in the such as the should be labeled as such in the such as the should be labeled as such in the such as the such as the should be labeled as such in the such as the such as the should be labeled as such in the such as t	been received.  been received in Application Nocuments have been received in this is of this communication to file a reply of this application.  ENT of this application.  Series reason(s) why the oath or declarate the submitted.  Son's Patent Drawing Review (PTO-Series Amendment / Comment or in the Office of the submitted o	national stage application from the complying with the requirements  S AMENDMENT or NOTICE OF tion is deficient.  948) attached  office action of	
<ol> <li>DEPOSIT OF and/or INFORMATION about the depos attached Examiner's comment regarding REQUIREMENT I</li> </ol>			
Attachment(s)  1. ☑ Notice of References Cited (PTO-892)  2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948)  3. ☑ Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 4/9/04  4. ☐ Examiner's Comment Regarding Requirement for Deposit	6. ☐ Interview Summary Paper No./Mail Dat 8), 7. ☐ Examiner's Amendo	e	
of Biological Material	9. Other LEE PRIMA	D. WILSON RY EXAMINER	

Art Unit: 3723

## REASONS FOR ALLOWANCE

The following is an examiner's statement of reasons for allowance: the art of record considered as a whole, alone or in combination, neither anticipates nor renders obvious a method of finishing a tracked semiconductor wafer having a semiconductor wafer surface and a finishing cycle time, the method comprising the steps of "changing a plurality of control parameters in response to an evaluation of both the in situ process information sensed with the at least three operative process sensors and the tracked information, wherein changing the control parameters changes the tangential force of friction in the at least one region having the finishing aid during at least a portion of the finishing cycle time" in combination as claimed in claims 1, 12, 19, 119; "changing a plurality of control parameters in response to an evaluation of both the in situ process information sensed with the at least three operative process sensors and the tracked information, wherein changing the control parameters changes the finishing rate measured in angstroms per minute in at least one uniform region during at least a portion of the finishing cycle time" in combination as claimed in claims 37, 56, 61, 76, 97; and "applying a finishing motion in the interface forming at least one uniform region having the finishing aid and a differential finishing rate measured in angstroms per minute on the semiconductor wafer surface; and changing a plurality of control parameters to change the differential finishing rate measured in angstroms per minute on the semiconductor wafer surface during the finishing cycle time" in combination as claimed in claim 59.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Anthony Ojini whose telephone number is 571 272 4492. The examiner can normally be reached on 7 to 4 Tuesday-Friday with every other Monday off.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Joseph Hail can be reached on 571 272 4485. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

AO 6/10/05